Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/809,462	FUKUI ET AL.	
Examiner	Art Unit	
Lv D. Pham	2827	

	SEAR	CHED	
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716	5, 6, 9, 10, 11, 14	4/27/2007	LP
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